IN THE CLAIMS:

The following is a complete listing of the claims in this application, reflects all changes currently being made to the claims, and replaces all earlier versions and all earlier listings of the claims:

1. (Currently amended) A probe for detecting <u>near-field</u> light or irradiating <u>near-field</u> light, comprising:

a cantilever <u>having first and second ends</u>, and <u>being</u> supported at an said first end thereof by a substrate <u>and having said second end free</u>;

a hollow tip formed at [[a]] said free end of said cantilever, said tip having an end;

a microaperture <u>for utilizing near field light</u> formed at <u>the said</u> end of said tip; and

a groove formed inside said cantilever, said groove comprising a hollow waveguide and a mirror[[;]].

wherein the direction of the end of said tip is substantially

perpendicular to the longitudinal direction of said cantilever, and said mirror is an end face

of the groove and reflects the light entering from the microaperture toward the hollow

waveguide or reflects the light transmitted in said hollow waveguide toward said

microaperture.

- 2. (Original) The probe according to Claim 1, wherein said waveguide has a V-shaped transversal cross section.
 - 3. (Original) The probe according to Claim 1, wherein said waveguide

has a trapezoidal transversal cross section.

- 4. (Original) The probe according to Claim 1, wherein said waveguide has a U-shaped transversal cross section.
- 5. (Original) The probe according to Claim 1, wherein said tip is shaped as a square cone.
 - 6. (Canceled)
- 7. (Original) The probe according to Claim 1, wherein said cantilever is principally composed of silicon.
 - 8. (Canceled)
- 9. (Original) The probe according to Claim 1, wherein said mirror is a concave mirror.
- 10. (Currently amended) A method for producing a probe for <u>utilizing</u>

 <u>near field light</u>, light detection or light irradiation, which comprises <u>said method</u>

 <u>comprising</u> the steps of:

working a <u>first</u> substrate to form a groove and a mirror at an end of <u>in</u> the groove therein;

said mirror being a slanted or a concave end face of the groove, forming a flat plate-shaped cover portion on the groove to form a

hollow waveguide having an opening in a part thereof[[,]];

forming a hollow tip having a microaperture on the opening, and removing a part of the substrate by etching, to form a cantilever preparing a second substrate having a recess portion;

forming a layer to become a tip layer in the recess portion;

aligning the first substrate having the flat cover portion and the

second substrate such that the flat cover portion and the layer are in contact with each other;

detaching the second substrate from the first substrate to form a

hollow tip having a microaperture on the opening; and

removing a part of the first substrate by etching, to form a cantilever.

- 11. (Currently Amended) The method according to Claim 10, wherein said the groove and said the mirror are formed by etching said the substrate.
- 12. (Currently Amended) The method according to Claim 11, wherein said the groove and said the mirror are formed by crystal-anisotropic etching of said the substrate.
- 13. (Currently Amended) The method according to Claim 10, further comprising a surface treatment step, of forming said the groove or said the cover portion into a mirror surface state.
- 14. (Currently Amended) The method according to Claim 10, wherein said the cover portion is formed from an SOI (silicon on insulator) layer of an SOI

substrate.

- 15. (Currently Amended) The method according to Claim 10, wherein said the cover portion is formed by filling said the groove with a resin layer and forming a metal film on said the resin layer.
- 16. (Currently Amended) The method according to Claim 10, wherein said step of forming said the hollow tip having said the microaperture on said the opening comprises the steps of:

forming a film of a tip material on a recess formed on a substrate,
transferring the tip material onto the opening, and
etching the end of a hollow tip resulting from the said transferring
step to form the microaperture.

- 17. (Currently amended) A surface observation apparatus <u>utilizing near</u> field light provided with at least one probe selected from the group consisting of probes according to any one of Claims 1 to 5, 7 and 9.
- 18. (Currently amended) An exposure apparatus <u>utilizing near field</u>
 <u>light</u> provided with at least one probe selected from the group consisting of probes
 according to any one of Claims 1 to 5, 7 and 9.
- 19. (Currently amended) An information processing apparatus <u>utilizing</u> near field light provided with at least one probe selected from the group consisting of probes according to any one of Claims 1 to 5, 7 and 9.

- 20. (Previously presented) A surface observation apparatus provided with at least one probe selected from the group consisting of probes produced by a method according to any one of Claims 10 to 16.
- 21. (Previously presented) An exposure apparatus provided with at least one probe selected from the group consisting of probes produced by a method according to any one of Claims 10 to 16.
- 22. (Previously presented) An information processing apparatus provided with at least one probe selected from the group consisting of probes produced by a method according to any one of Claims 10 to 16.
- 23. (Previously presented) A probe according to Claim 1, wherein said mirror is a slanted face.
- 24. (Previously presented) The probe according to Claim 1, wherein a light toward the microaperture reflected by the mirror generates near field light in the vicinity of the microaperture.
- 25. (Previously presented) The probe according to Claim 1, wherein a light toward the hollow waveguide reflected by the mirror is a propagating light passing through the microaperture.